

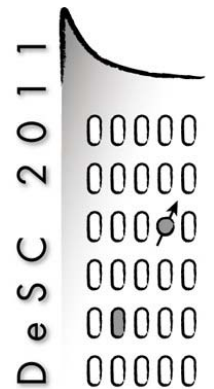
Program of the Workshop on

DEFECTS IN SEMICONDUCTORS AND THEIR CHARACTERIZATION

A workshop in the framework of FAHL ACADEMIA.
Hörsaal für Theoretische Physik, Linnéstraße 5, 04103 Leipzig

Tuesday, 20th September 2011

- 9:00 Welcome address
- 9:15 **Tony Peaker**
University of Manchester
Deep Level Transient Spectroscopy and Shockley-Hall-Reed
Recombination
- 10 :00 Coffee break
- 10:30 **Francois Danie Auret**
University of Pretoria
Laplace-DLTS and its Applications
- 11:15 **Lukas Eng**
Technische Universität Dresden
Semiconductors analyzed by Scanning Probe Methods
- 12:00 Lunch
- 13:30 Postersession
- 14:30 **Martin Albrecht**
Leibniz-Institut für Kristallzüchtung Berlin
Transmission Electron Microscopy of Alloys, Defects and Interfaces in
Semiconductors
- 17:00 Social Program – Guided Tour through Leipzig’s city centre
Meeting Point: Augustusplatz, Mendebrunnen
- 19:00 Conference Diner and Award Ceremony in the *Ratskeller Leipzig*



Wednesday 21st September 2011

- 9:30 **Matthias Schmidt**
Universität Leipzig
Space Charge Layer Spectroscopy with Optical Excitation
- 10:15 Coffee break
- 10:45 **Reinhard Krause-Rehberg**
Universität Halle-Wittenberg
Defects in Semiconductors Studied by Positron Annihilation
- 11:30 **Walter E. Meyer**
University of Pretoria
Metastable Defects
- 12:15 Lunch